Effect of thermal and mechanical loadings on the residual stress field in a nickel based superalloy using X-ray Laue microdiffraction

Gader Altinkurt, Mathieu Fèvre, Guillaume Geandier, Odile Robach, Soufiane Guernaoui, Moukrane Dehmas

To cite this version:

Gader Altinkurt, Mathieu Fèvre, Guillaume Geandier, Odile Robach, Soufiane Guernaoui, et al.. Effect of thermal and mechanical loadings on the residual stress field in a nickel based superalloy using X-ray Laue microdiffraction. ICRS- Australie-International Conference on Residual Stresses, Jul 2016, SYDNEY, Australia. <hal-01436664>
Effect of thermal and mechanical loadings on the residual stress field in a nickel based superalloy using X-ray Laue microdiffraction

Gader Altinkurt1,2,a, Mathieu Fèvre1,b, Guillaume Geandier2,c, Odile Robach3,4,d, Soufiane Guernaoui2,e and Moukrane Dehmas2,f

1 LEM, UMR 104 CNRS-Onera, Châtillon, France
2 IJL, UMR 7189 CNRS-Université de Lorraine, Nancy, France
3 CRG-IF BM32 at ESRF Grenoble, France
4 CEA, INAC-SP2M, Grenoble, France
5,6 gader.altinkurt@onera.fr, mathieu.fevre@onera.fr, guillaume.geandier@univ-lorraine.fr, odile.robach@cea.fr, soufiane.xr@gmail.com, moukrane.dehmas@univ-lorraine.fr

Keywords: Laue microdiffraction, residual deviatoric strain, shot-peening, fatigue, coarse-grained crystal, nickel based superalloy.

Abstract. The shot-peening operation is used to improve the fatigue lifetime of mechanical components through the introduction of compressive residual stresses and plastic deformation in a surface layer. In this study, the Laue microdiffraction technique is used to investigate deviatoric strain fields caused by the shot-peening operation and their redistribution after fatigue testing in a nickel-based polycrystalline superalloy with a 40 µm average grain size.

Introduction

Nickel-based polycrystalline superalloys elaborated by powder metallurgy are used in high pressure turbine discs of aircraft engines. Specific compositions, microstructures and mechanical treatments are developed to improve the resistance of crack propagation, creep and fatigue during service. The shot-peening process is used extensively to delay crack initiation in the surface layer of components by introducing compressive residual stresses and plastic deformation. The determination of such stresses is generally performed with diffraction based techniques using the sin²Ψ method and the effect of temperature and fatigue conditions on stresses relaxation has been deeply investigated in fine-grained microstructures. Most outcomes are associated with macroscopic properties of the average alloy. At the grain scale, electron backscattered diffraction and transmission electron microscopy were employed to characterize plastic deformation and dislocation densities after the shot-peening operation [1]. Even if compressive residual stresses have been relaxed, high dislocation densities persist in the microstructure providing hardening and resistance. A complete understanding of the relationship between the microstructure (precipitate and grain sizes) and residual stresses is still missing. With the Laue microdiffraction technique, stress states and geometrically necessary dislocation densities can be investigated at the grain and phase scales. The technique has already been used to understand the dislocation mechanism in grains under a tensile loading [2], near to grain boundary during a fatigue loading [3] or in zone heavily deformed by friction stir welding [4]. Local deviatoric strain or stress tensors have been also determined in areas close to scratches [5] and cracks [6] or under a tensile loading [7]. The Laue microdiffraction technique has not been employed to characterize strain fields in shot-peened nickel-based superalloys. This method is in principle a suitable tool for macroscopic and microscopic stress determination in coarse grained microstructures since the sin²Ψ method is not well adapted to investigations in such microstructures.

In this paper, deviatoric strain fields generated by the shot-peening operation and then redistributed by a low cycle fatigue (LCF) test at 450°C are characterized in a nickel-based superalloy with a 40 µm average grain size.
Experimental conditions

Sample features. Cylindrical specimens were removed using Electro Discharge Machining in a sector of a turbine disk of the N18 superalloy [8] produced at Snecma (SAFRAN group). The microstructure consists in γ’ hardening precipitates with a simple cubic structure embedded in a γ matrix phase with a face-centered cubic structure. A coarse grained microstructure with one population of γ’ precipitates is obtained after a supersolvus solution treatment (4 hours at 1205°C and air quench) followed by an ageing treatment (1h at 900°C and air quench). At the millimetre scale, the analysis of the Electron Back Scattered Diffraction (EBSD) images acquired in the Scanning Electron Microscope (SEM) shows an average γ grain size of 40 µm with a wide distribution ranging from 5 µm to 200 µm (Fig. 1b). At the micrometer scale, SEM micrographs show cubic shape γ’ precipitates with an average size close to 200 nm homogeneously distributed in the γ matrix (Fig. 1c). In order to simplify the x-ray data analysis and to dissociate physical mechanisms in such materials, this microstructure sensibility differs from those employed in aircraft engines (5-20 µm grain sizes and three populations of γ’ precipitates [8]). Three 6.22 mm diameter fatigue test specimen were then machined. One was used as a reference. One was subjected to shot-peening, one to shot-peening and interrupted fatigue testing. The peening operation was done using an ultrasonic technique with 3 mm-diameter 100Cr6 steel shots during 1080s. The fatigue test was performed at imposed deformation (Δε/2 = 0.5 %, Rε = 0) at 450°C during 300 cycles. 10 mm height samples were finally cut perpendicular to the shot-peened surface in the gauge length. X-ray measurements were performed in a circular cross section which has been mechanically and chemically polished to reduce stresses introduced by the cutting process.

Fig. 1: (a) sample geometry with the local cylindrical coordinate system (, , ). (b) EBSD map revealing grains γ (random colours). (c) SEM micrograph showing γ’ precipitates (dark grey) embedded in the γ matrix (light grey).

µ-Laue technique. Laue microdiffraction was performed at the BM32 beamline of the European Synchrotron Radiation Facility at Grenoble (France). A polychromatic beam with a 5-17 keV energy spectrum is focused to a cross section of 0.35 x 0.6 µm² at the sample position. Emerging X-rays are collected on a CCD 2D detector oriented in 90° with respected to the incident beam in reflection geometry (see Ref. [9] for a more detailed description of the setup). A xyz motorized sample stage enables to record Laue patterns arising from different locations at the sample surface. With this setup, the characteristic penetration depth of the beam in the material ranges from 4 µm to 15 µm and up to one frame per 5 second can be acquired. Due to the grain size and the cross section of the beam, our samples behave like single crystals and the Laue pattern consists in spots. The Miller indices of each spot can be retrieved from the crystal symmetry and peak positions in pattern. Based on the formulation proposed by Chung and Ice [10], the indexation of four diffraction peaks permits to determine the orientation of the crystal lattice regarding to the coordinate system of the experiment and five of the six unit cell parameters: two lengths ratio and three angles usually denoted by b/a, c/a and α, β, γ respectively. The knowledge of these parameters for a non-deformed structure (a₀, b₀, c₀, α₀, β₀, γ₀) enables to determine the deviatoric elastic strain tensor ε̃ within the small transformation approximation. Its coefficients are given by:
\[
\varepsilon^d_{ij} = \varepsilon_{ij} - \operatorname{Tr}(\varepsilon) \delta_{ij}/3 \quad i,j=1,2,3
\]

where \( \varepsilon \) is the total strain tensor and \( \delta_{ij} \) the Kronecker delta function. \( \varepsilon^d \) is associated with the distortion of the crystal unit cell. When the stiffness tensor of the single crystal is known, the deviatoric stress tensor can be deduced by applying the generalized Hooke’s law.

**Data processing**

Due to the highly coherent interfaces (lattice mismatch < 10^{-3}), fundamental reflections \((h,k,l)\) with the same parity correspond to the convolution of the intensities belonging to the \( \gamma \) and \( \gamma' \) phase whereas superstructure reflections \((h,k,l)\) with different parities correspond only to the contribution of the \( \gamma' \) phase intensities. Laue patterns provide thus quantitative information about the average alloy \((\gamma + \gamma')\) and the \( \gamma' \) phase. Data analysis has been performed using the XMAS [11] and LaueTool [12] softwares. The main output of the calculations is the coordinates of the reciprocal lattice vectors in a given system of coordinates (sample, laboratory) for each crystallite founded in the Laue pattern. This is then used to determine the crystal orientation, its unit cell parameters and finally deviatoric strain and stress components. The strain-free lattice-parameters of the \( \gamma \) and \( \gamma' \) phases have been determined for the fine grain N18 alloy [8] using chemical etching and powder diffraction measurements. A Vegard’s law is used to determine the strain free lattice-parameter associated with the average alloy \((a_0=0.35917 \text{ nm})\). With the Laue technique, the strain sensitivity can be 5.10^{-5} when optimal conditions are reached [13] but generally, it is closer to 1-2.10^{-4} [5,10]. In this study, the assessment of uncertainties in a sample which has not been subjected to shot-peening results in a 2.10^{-4} uncertainty on strain values.

**Results and discussions**

In the following, results associated with the analysis of the fundamental reflections \((\gamma + \gamma')\) are presented. The crystal orientation is expressed with respect to the fixed laboratory coordinate system within the axis–angle representation. Based on the sample geometry and the applied external loadings, the deviatoric strain components \(\varepsilon^d_{ij}\) are given with respect to the local cylindrical coordinate system \((\rho, \theta, z)\). \(\rho\), \(\theta\) correspond to radial and circumferential axis and \(z\) is the axis aligned with the free surface normal (Fig.1a). The single-crystal elastic constants of the N18 are unknown. To avoid bad physical interpretations, only strain tensor components are discussed below. Since the deviatoric strain components associated with the \(z\) direction could be affected by the presence of the free surface, only \(\varepsilon^d_{rr}, \varepsilon^d_{\theta\theta}\) and \(\varepsilon^d_{r\theta}\) are discussed below. Orientation and strain xy maps are obtained from meshes with steps corresponding to the beam size.

**Reference sample.** Measurements in the sample which has not been subjected to shot-peening have been realized on a 1x3 mm² area. No strain heterogeneities between identified grains were observed. Strain components smoothly evolve with values close to the sensitivity limit of the technique (±2.10^{-4}) excepting for the \(\varepsilon^d_{zz}\) component which is between -3.10^{-4} and -6.10^{-4}. This is probably due to the surface polishing realized during the sample preparation. Such values of deviatoric strains have also been obtained by Chao et al [6] with the same technique in a nickel-based Alloy 600 sample before tensile deformation. The analysis also shows that strains in the order of ±1.5x10^{-5} caused by the grinding machine used develop over a layer with a thickness lower than 100 µm.
Figure 2: Local orientation and deviatoric elastic strain component maps for a sample which has been subjected to shot-peening on the left and to shot-peening and an interrupted fatigue test at 450°C on the right. Orientation maps are determined within the axis-angle representation.

**Effect of shot-peening.** Measurements in the sample which has been subjected to shot-peening have been realized on a 1.02x0.225 mm² area close to its edge. The xy-orientation map and the maps associated with the components of the deviatoric strain tensor are represented in figure 2 (a-d). Lines in figure 2a correspond to radius contours and the edge of the sample is located at the right side of the figure (last contour line). In the first 300 µm wide area close to sample edge (white color), the material hardening introduced by the shot-peening has caused large intensity spread in the Laue pattern. It was not possible to accurately quantify strain tensor components. Figures 2b to 2d show different components of the strain field. Along the average peening direction (Fig. 2b), the deviatoric strain component strongly depends on the distance from the sample centre (negative for 2.0 mm < x < 2.5 mm and positive for 2.5 mm < x < 2.7 mm) and has a less pronounced variations along contours. Strain amplitudes range is from $-4 \times 10^{-3}$ to $4.5 \times 10^{-3}$. Along the circumferential direction (Fig. 2c), the deviatoric strain component has also this dependency with a negative sign. Some variations can be observed close to several grain boundaries. Strain amplitudes range is from $-4.5 \times 10^{-3}$ to $1.10^{-3}$. In figure 2d, the $\varepsilon_d^{d_\theta\theta}$ component has a heterogeneous behaviour with strain levels much more dependent on the microstructure and a range from $-2.10^{-3}$ to $2.10^{-3}$. For all components, we clearly observe that after shot peening, high shear strains take place deeply in the material. Indeed, at a distance of 1mm, all components differ significantly from zero. In order to compare Laue microdiffraction results to those which could be obtained in the laboratory with a beam section close to square millimetres, strain values can be averaged along the radius contour lines of figure 2a. Results are represented as a function of the distance from the shot-peened edge in figure 3a. Because of the dependency of the deviatoric strain at this scale, this representation is justified. The $\varepsilon_d^{d_\theta\theta}$ and $\varepsilon_d^{d_\theta\rho}$ components follow trends described previously. A large variation of strains is visible in a layer located between 0.3 mm and 0.6 mm depths and they evolve smoothly further. The $\varepsilon_d^{d_\theta\rho}$ component is close to zero for all depths and the presence of strong local heterogeneities is not discernable with this average.
Effect of fatigue. Figure 2e-h represents the orientation and the deviatoric strain maps obtained from measurements in the sample which has been shot-peened and then subjected to low-cycle fatigue at 450°C during 300 cycles. The investigated area is 1.01x0.125 mm² close to a sample edge. The deviatoric strain fields observed just after the shot-peened in figures 2b to 2d have been strongly modified by the thermal and mechanical loading. All components exhibit positive and negative heterogeneous strains in the whole area with amplitudes comparable to what has been determined previously \((-3.10^{-3} < \varepsilon^d < 4.10^{-3}\)). By contrast with the shot-peened state, the axial and the circumferential deviatoric strains are independent on the distance from the sample edge and more influenced by each grain features. Strain values averaged along the radius contour lines are represented as a function of the distance from the shot-peened edge in figure 3b. On the few considered grains, the \(\varepsilon^d_R\) component behaves similarly for these two states. However, some relaxation is visible for the two other components after fatigue. To have a better statistic and probe a large number of grains, strain profiles from a 2x2mm² map (not shown) with a smaller spatial resolution are plotted in figure 3c. At this scale, all components differ significantly from zero up to a distance of 0.4 mm from the sample edge. The highest strain amplitudes are close to 1x10^{-3} and take place close to the shot-peened surface. Most of the fluctuations visible in figure 3b are removed by the averaging procedure and the \(\varepsilon^d_R\) component behaves differently close to the sample edge in figure 3b and 3c. These results highlight the fact that large local strains occur in the microstructure even though no strain is determined with a method involving averages on many grains as with the \(\sin^2 \Psi\) method. Consequently, a good understanding of the role of the microstructure on the fatigue properties of materials requires investigations at the grain scale.

Conclusions

The Laue microdiffraction technique has been used to investigate deviatoric strain fields in nickel-based superalloy samples with a coarse grained microstructure and subjected to ultrasonic shot-peening and fatigue testing at 450°C. This method is suitable for investigations in coarse grained microstructures as an alternative to conventional techniques and provides additional information at the grain scale. The method should able to study the plastic deformation induced by shot-peening with the study of peaks shape. It should able to provide new data on the influence of the \(\gamma^3\) precipitates on internal stresses in superalloys. However, information from the highly strained 300 µm thick region close to the surface could not be obtained as Laue patterns could not be indexed with a good accuracy. Moreover, the mapping of the full strain tensor is still a challenging task.

Measurements at the grain scale have shown that residual elastic strains with amplitudes ranging from -4 to 4.10^{-3} take place at depths larger than 1 mm. The redistribution of strain fields associated with the shot-peening operation was also clearly observed after 300 cycles of fatigue at 450°C. In
particular, the dependence of axial and circumferential strains with the distance from the shot-peened surface observed just after the shot-peening operation has completely disappeared after fatigue leaving to heterogeneous positive and negative fields with a strong dependence on the underlying microstructure.

Acknowledgments
This work benefited from the support of the project REMEDDIES ANR-13-BS09-016 of the French National Research Agency (ANR). The experiments were performed on beamline BM32 at the European Synchrotron Radiation Facility (ESRF), Grenoble, France. We are grateful to Local Contact at the ESRF for providing assistance in using beamline BM32.

Reference